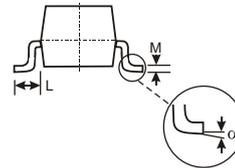
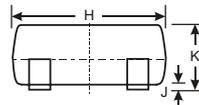
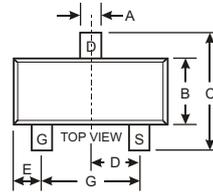


### Features

- Advanced trench process technology.
- High Density Cell Design For Ultra Low On-Resistance.
- Fully Characterized Avalanche Voltage and Current.
- Improved Shoot- Through FOM.
- We declare that the material of product compliance with RoHS requirements.



SOT-23		
Dim	Min	Max
A	0.37	0.51
B	1.20	1.40
C	2.30	2.50
D	0.89	1.03
E	0.45	0.60
G	1.78	2.05
H	2.80	3.00
J	0.013	0.10
K	0.903	1.10
L	0.45	0.61
M	0.085	0.180
$\alpha$	0°	8°
All Dimensions in mm		

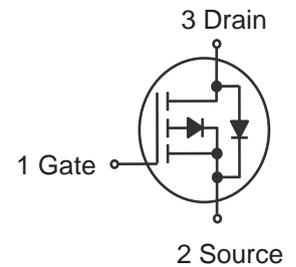
### APPLICATIONS

- TrenchFET Power MOSFET.
- Load Switch for Portable Devices.
- DC/DC Converter.
- Marking Code:S5 OR A5SHB .

### Maximum Ratings @ $T_A = 25^\circ\text{C}$ unless otherwise specified

Parameter	Symbol	Value	Unit
Drain-Source Voltage	$V_{DS}$	-20	V
Gate-Source Voltage	$V_{GS}$	$\pm 12$	V
Drain Current	$I_D$	-4.1	A
Pulsed Drain Current	$I_{DM}$	-10	A
Maximum Power Dissipation	$P_D$	0.96	W
Thermal Resistance from Junction to Ambient (PCB mounted) <sup>1)</sup>	$R_{\theta JA}$	130	$^\circ\text{C}/\text{W}$
Junction Temperature	$T_J$	150	$^\circ\text{C}$
Storage Temperature Range	$T_{stg}$	- 55 to + 150	$^\circ\text{C}$

<sup>1)</sup> 1 in<sup>2</sup> 2oz Cu PCB board.





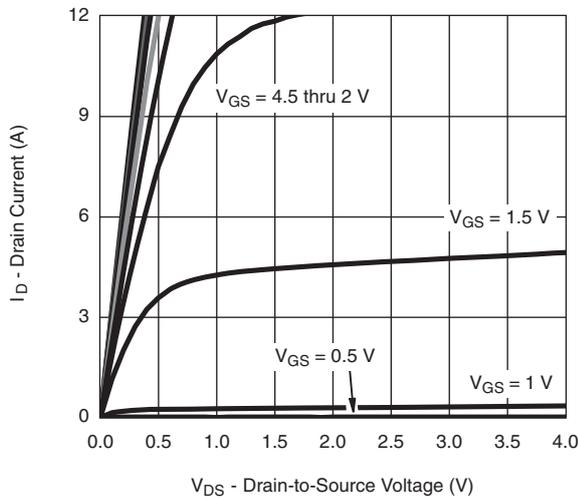
### Electrical Characteristics @ $T_A = 25^\circ\text{C}$ unless otherwise specified

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
<b>Static</b>						
Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = -250\mu A$	-20			V
Gate-source threshold voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = -250\mu A$	-0.4	-0.7	-1.0	
Gate-source leakage	$I_{GSS}$	$V_{DS} = 0V, V_{GS} = \pm 12V$			$\pm 100$	nA
Zero gate voltage drain current	$I_{DSS}$	$V_{DS} = -20V, V_{GS} = 0V$			-1	$\mu A$
Drain-source on-state resistance <sup>e</sup>	$R_{DS(on)}$	$V_{GS} = -4.5V, I_D = -4.1A$		28	45	m $\Omega$
		$V_{GS} = -2.5V, I_D = -3.0A$		39	58	
		$V_{GS} = -1.8V, I_D = -2.0A$		54	75	
Forward transconductance <sup>a</sup>	$g_{fs}$	$V_{DS} = -5V, I_D = -4.1A$		6		S
<b>Dynamic</b>						
Input capacitance <sup>b,c</sup>	$C_{iss}$	$V_{DS} = -4V, V_{GS} = 0V, f = 1MHz$		740		pF
Output capacitance <sup>b,c</sup>	$C_{oss}$			290		
Reverse transfer capacitance <sup>b,c</sup>	$C_{rss}$			190		
Total gate charge <sup>b</sup>	$Q_g$	$V_{DS} = -4V, V_{GS} = -4.5V, I_D = -4.1A$		7.8		nC
		$V_{DS} = -4V, V_{GS} = -2.5V, I_D = -4.1A$		4.5		
Gate-source charge <sup>b</sup>	$Q_{gs}$			1.2		
Gate-drain charge <sup>b</sup>	$Q_{gd}$			1.6		
Gate resistance <sup>b,c</sup>	$R_g$	$f = 1MHz$	1.4	7	14	$\Omega$
Turn-on delay time <sup>b,c</sup>	$t_{d(on)}$	$V_{DD} = -4V, R_L = 1.2\Omega, I_D \approx -4.1A, V_{GEN} = -4.5V, R_g = 1\Omega$		13	20	ns
Rise time <sup>b,c</sup>	$t_r$			35	53	
Turn-off Delay time <sup>b,c</sup>	$t_{d(off)}$			32	48	
Fall time <sup>b,c</sup>	$t_f$			10	20	
Turn-on delay time <sup>b,c</sup>	$t_{d(on)}$			5	10	
Rise time <sup>b,c</sup>	$t_r$			11	17	
Turn-off delay time <sup>b,c</sup>	$t_{d(off)}$			22	33	
Fall time <sup>b,c</sup>	$t_f$			16	24	
<b>Drain-source body diode characteristics</b>						
Continuous source-drain diode current	$I_S$	$T_C = 25^\circ\text{C}$			-1.4	A
Pulse diode forward current <sup>a</sup>	$I_{SM}$				-10	
Body diode voltage	$V_{SD}$	$I_F = -4.1A$			-1.2	V

**Note :**

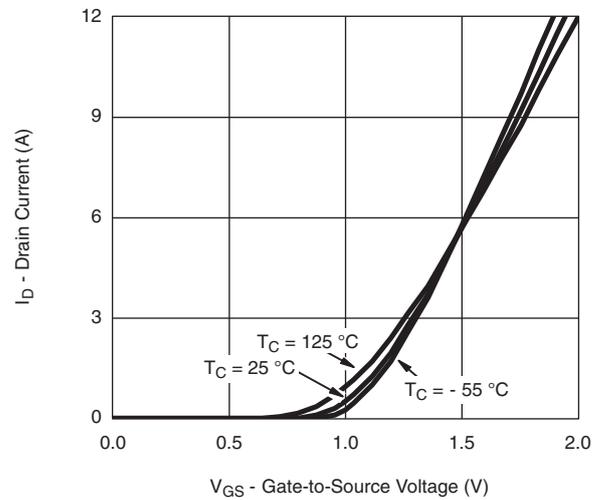
- a. Puls Test ; Pulse Width  $\leq 300\mu s$ , Duty Cycle  $\leq 2\%$ .
- b. Guaranteed by design, not subject to production testing.
- c. These parameters have no way to verify.

### TYPICAL TRANSIENT CHARACTERISTICS



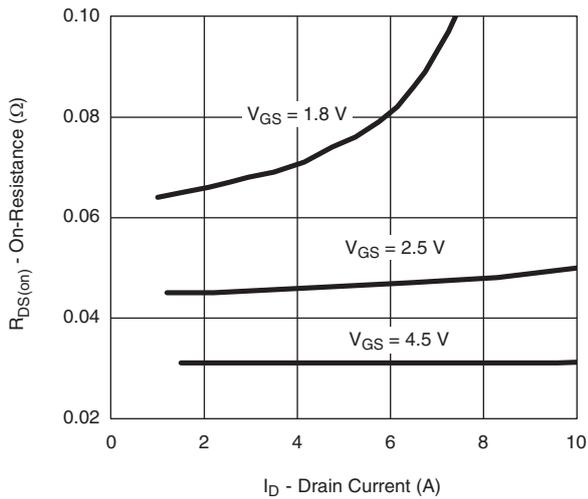
$V_{DS}$  - Drain-to-Source Voltage (V)

**Output Characteristics**

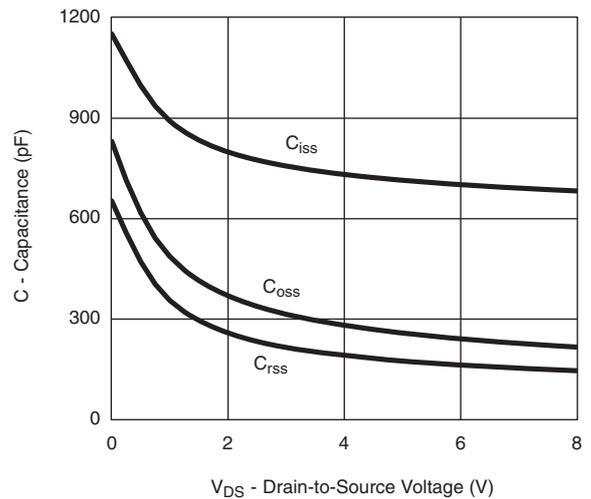


$V_{GS}$  - Gate-to-Source Voltage (V)

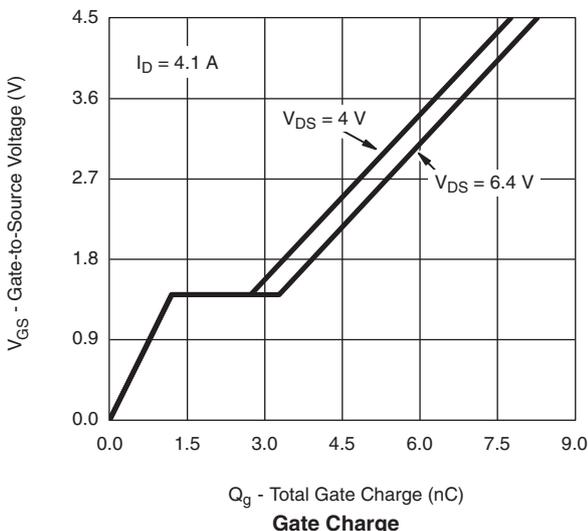
**Transfer Characteristics**



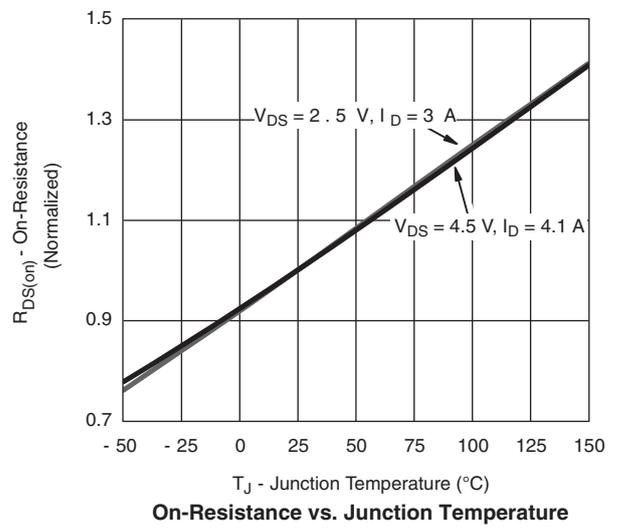
**On-Resistance vs. Drain Current and Gate Voltage**



**Capacitance**

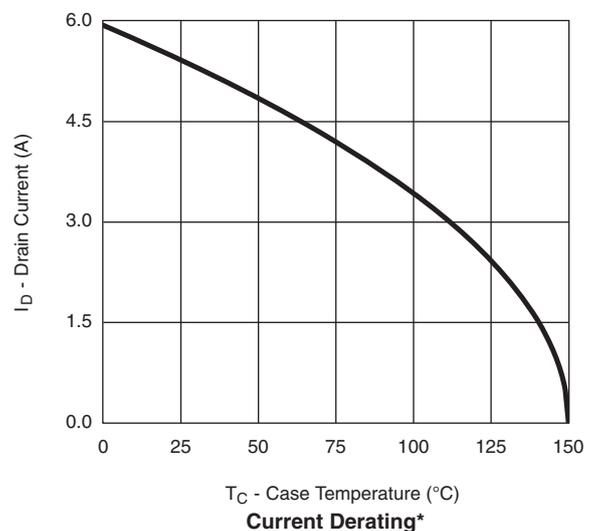
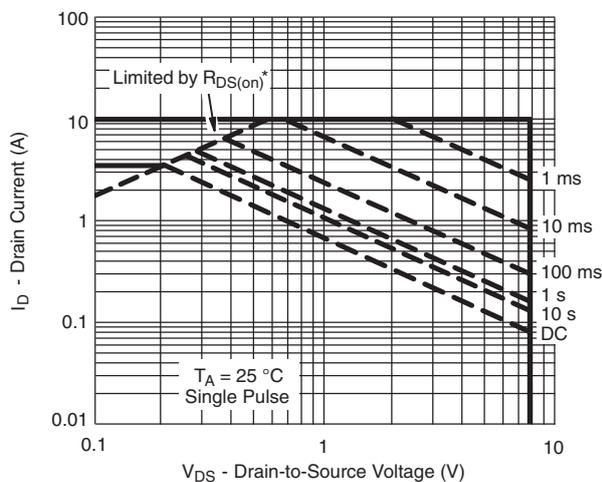
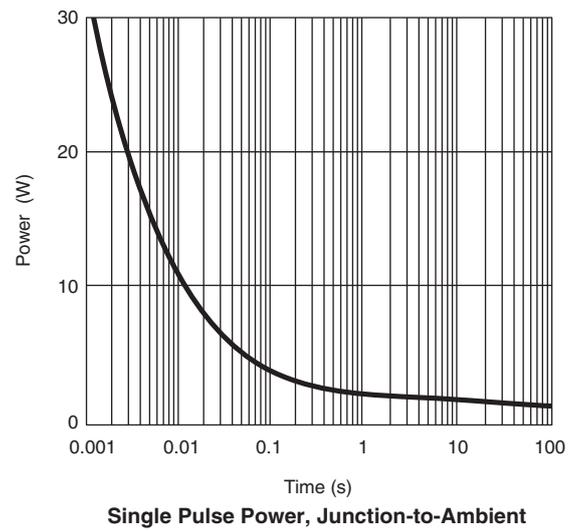
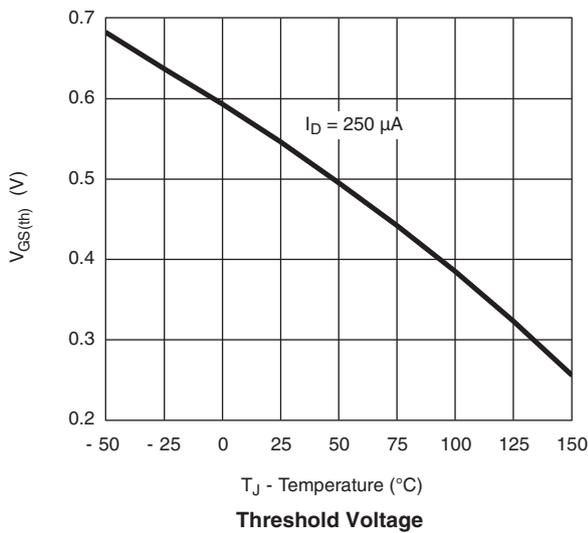
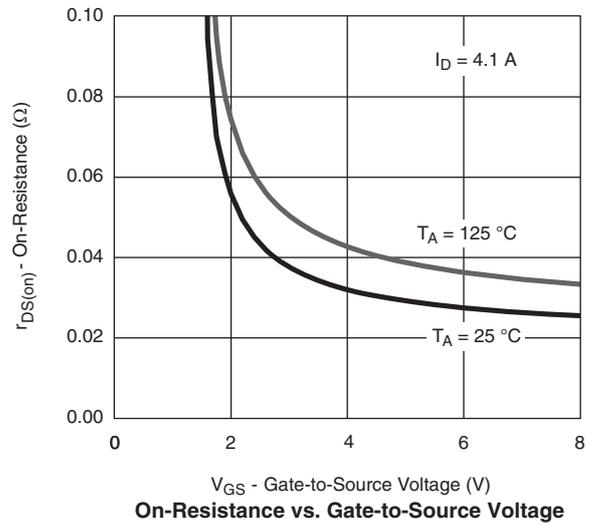
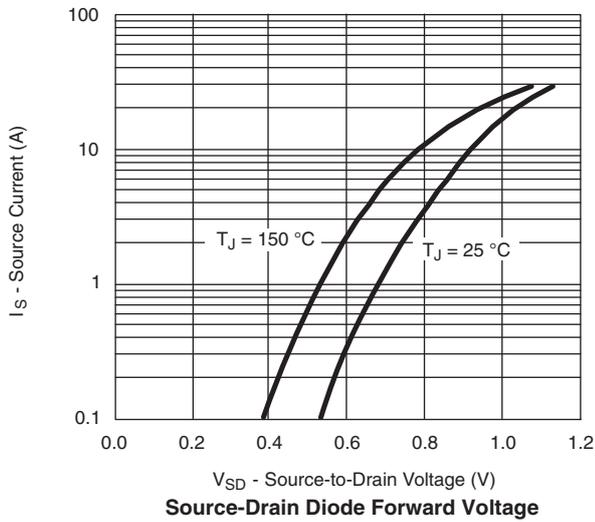


**Gate Charge**



**On-Resistance vs. Junction Temperature**

### TYPICAL TRANSIENT CHARACTERISTICS

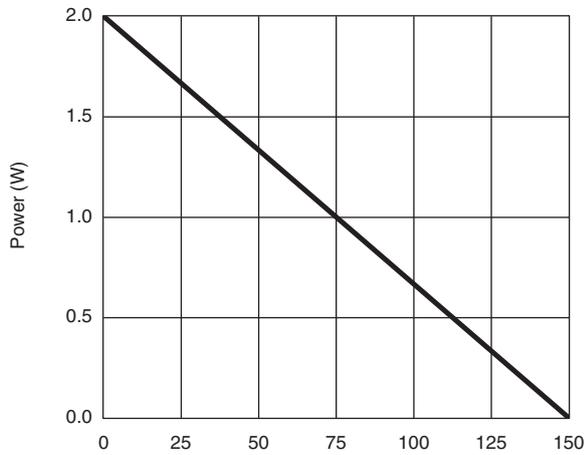


\*  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified  
**Safe Operating Area, Junction-to-Ambient**

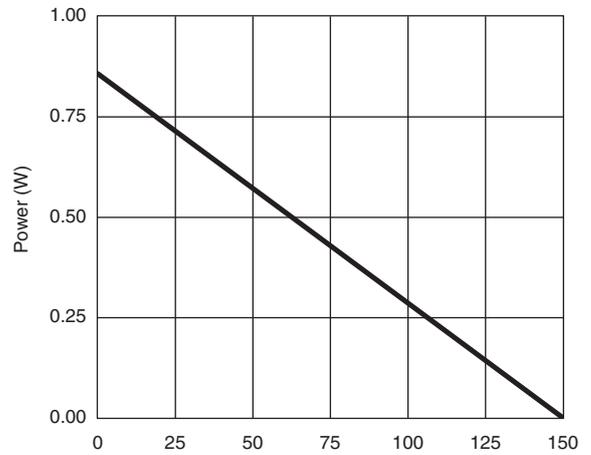
**Current Derating\***



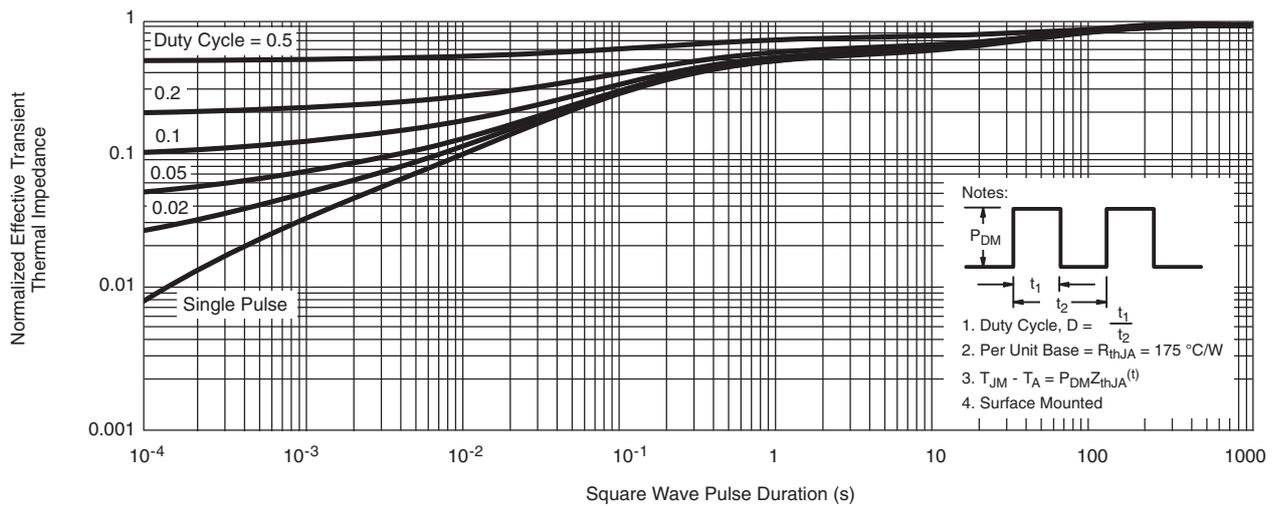
### TYPICAL TRANSIENT CHARACTERISTICS



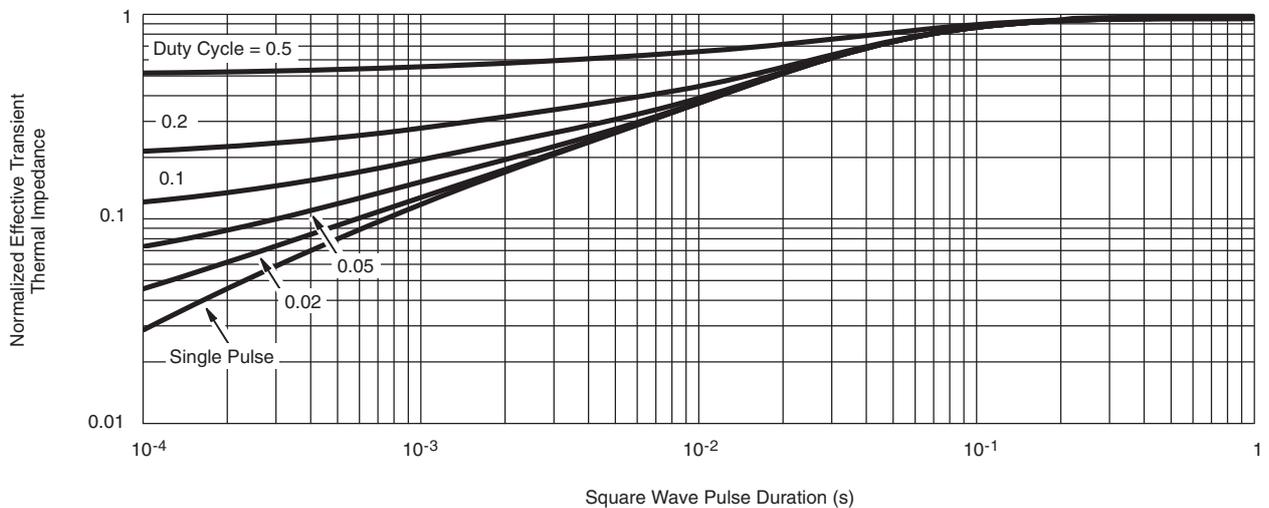
$T_C$  - Case Temperature (°C)  
**Power, Junction-to-Case**



$T_A$  - Ambient Temperature (°C)  
**Power, Junction-to-Ambient**



**Normalized Thermal Transient Impedance, Junction-to-Ambient**



**Normalized Thermal Transient Impedance, Junction-to-Foot**

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## **IMPORTANT NOTICE**

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